# MOSFET – Power, Single N-Channel 60 V, 21 mΩ, 27 A

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK4 Package, Industry Standard
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage	9		$V_{GS}$	±20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	27	Α
Current R <sub>θJC</sub> (Notes 1, 2, 3)	State	T <sub>C</sub> = 100°C		15	
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	28	W
R <sub>θJC</sub> (Notes 1, 2)		T <sub>C</sub> = 100°C		9.0	
Continuous Drain Current R <sub>0.IA</sub>	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	9.8	Α
(Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C		6.9	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.8	W
H <sub>0JA</sub> (Notes 1 & 2)	R <sub>0JA</sub> (Notes 1 & 2)			1.9	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	131	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	°C
Source Current (Body Diode)			I <sub>S</sub>	23.5	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 1.1 A)			E <sub>AS</sub>	43	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Junction-to-Case - Steady State	$R_{\theta JC}$	5.3	°C/W	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39		

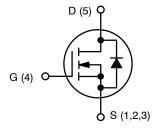
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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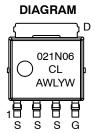
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	21 mΩ @ 10 V	07.4
60 V	31.5 m $\Omega$ @ 4.5 V	27 A



**N-CHANNEL MOSFET** 



#### LFPAK4 CASE 760AB



**MARKING** 

021N06CL = Specific Device Code A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				28		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10	
		V <sub>DS</sub> = 60 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 16 \mu A$		1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		18	21	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 10 A		26	31.5	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> =15 V, I <sub>D</sub> = 10 A			37		S
CHARGES AND CAPACITANCES	•						•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			410		
Output Capacitance	C <sub>OSS</sub>				210		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				7.0		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 48 V; I <sub>D</sub> = 10 A			2.5		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 48 V; I <sub>D</sub> = 10 A			5.0		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 48 V; I <sub>D</sub> = 10 A			0.6		
Gate-to-Source Charge	Q <sub>GS</sub>				1.0		nC
Gate-to-Drain Charge	$Q_{GD}$				0.5		1
Plateau Voltage	V <sub>GP</sub>				2.7		V
SWITCHING CHARACTERISTICS (Note 5	)				•	•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				4.0		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	c = 48 V.		12		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 10 \text{ A}, R_G = 2.5 \Omega$			12		ns
Fall Time	t <sub>f</sub>				1.5		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.9	1.2	
		I <sub>S</sub> = 10 A	T <sub>J</sub> = 125°C		0.8		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			18		
Charge Time	t <sub>a</sub>				9.0		ns
Discharge Time	t <sub>b</sub>				9.0		1
Reverse Recovery Charge	Q <sub>RR</sub>				7.0		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

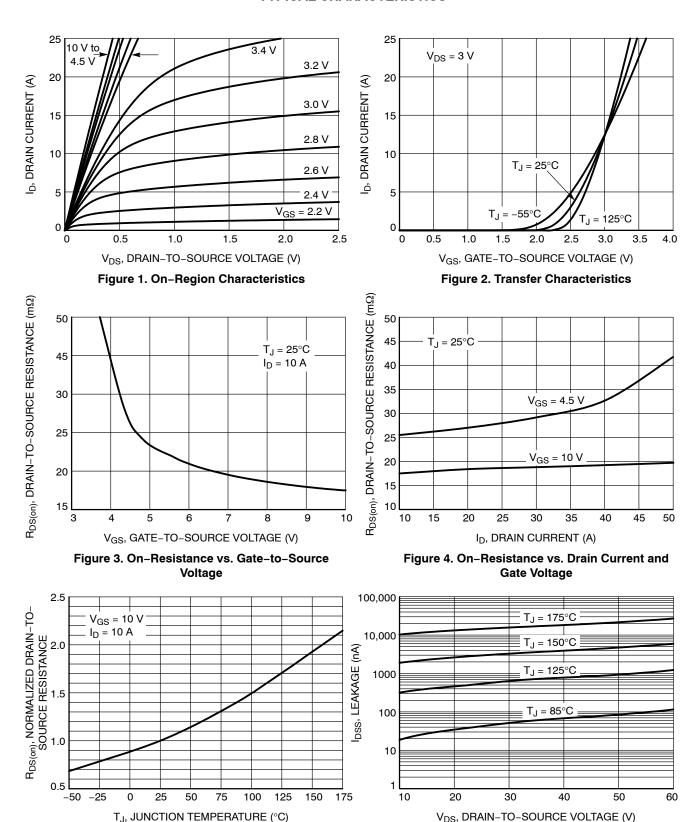


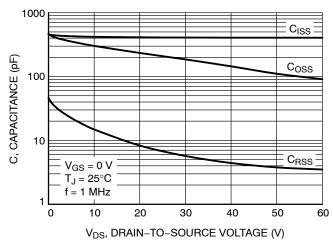
Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

**Temperature** 

#### **TYPICAL CHARACTERISTICS**

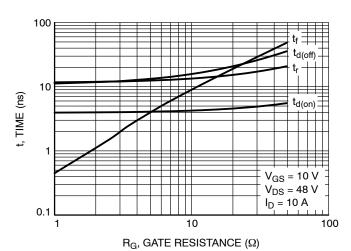


V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) 8 7 6 5 4  $Q_{GS}$  $Q_{GD}$ 3  $V_{DS} = 48 \text{ V}$ 2 T<sub>J</sub> = 25°C  $I_D = 10 A$ 0 2

 $Q_T$ 

Figure 7. Capacitance Variation

Q<sub>G</sub>, TOTAL GATE CHARGE (nC) Figure 8. Gate-to-Source vs. Total Charge



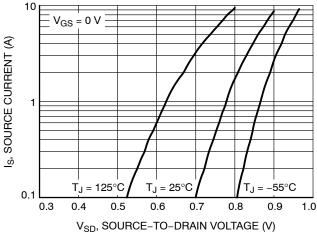
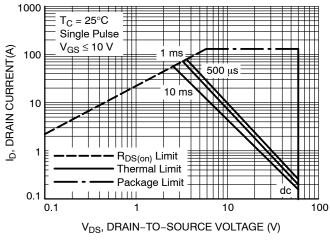


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



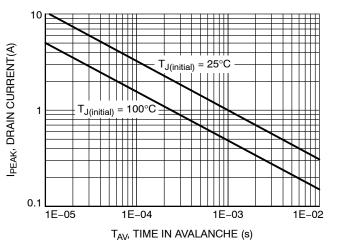


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Drain Current vs. Time in **Avalanche** 

#### **TYPICAL CHARACTERISTICS**

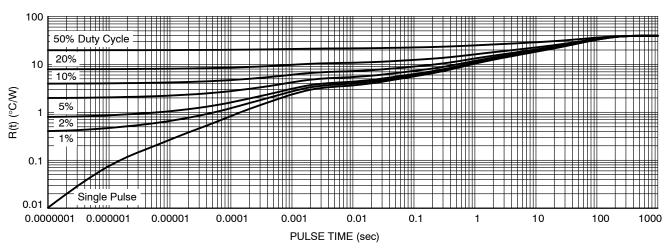
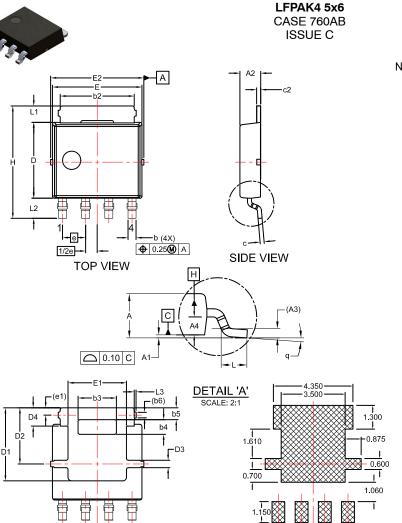


Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMYS021N06CLTWG	021N06CL	LFPAK4 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



**DATE 19 NOV 2019** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

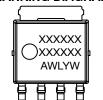
UNIT IN MILLIMETER			
DIM	MIN	NOM	MAX
Α	1.10	1.20	1.30
A1	0.00	0.08	0.15
A2	1.10	1.15	1.20
A3	(	).25 REF	=
A4	0.45	0.50	0.55
b	0.40	0.45	0.50
b2	3.80	4.10	4.40
b3	2.00	2.10	2.20
b4	0.70	0.80	0.90
b5	0.55	0.65	0.75
b6	_	0.31 REI	
С	0.19	0.22	0.25
c2	0.19	0.22	0.25
D	4.05	4.15	4.25
D1	3.80	4.00	4.20
D2	3.00	3.10	3.20
D3	0.30	0.40	0.50
D4	0.90	1.00	1.10
Е	4.80	4.90	5.00
E1	3.10	3.20	3.30
E2	5.00	5.15	5.30
е		1.27 BS0	
1/2e	0.635 BSC		
e1	0.40 REF		
Н	6.00	6.15	6.30
L	0.40	0.65	0.85
L1	0.80	0.90	1.00
L2	0.90	1.10	1.30
L3	0.00	0.10	0.20
q	0°	4°	8°

## RECOMMENDED LAND PATTERN

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

# GENERIC MARKING DIAGRAM\*

**BOTTOM VIEW** 



XXXXXX = Specific Device Code A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking.

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